

# FS30UM-3

HIGH-SPEED SWITCHING USE

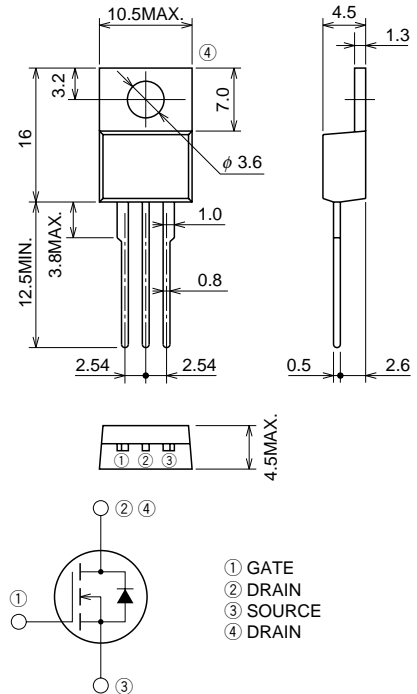
## FS30UM-3



- 10V DRIVE
- V<sub>DSS</sub> ..... 150V
- r<sub>DS (ON)</sub> (MAX) ..... 92mΩ
- I<sub>D</sub> ..... 30A
- Integrated Fast Recovery Diode (TYP.) ..... 110ns

## OUTLINE DRAWING

Dimensions in mm



TO-220

## APPLICATION

Motor control, Lamp control, Solenoid control  
DC-DC converter, etc.

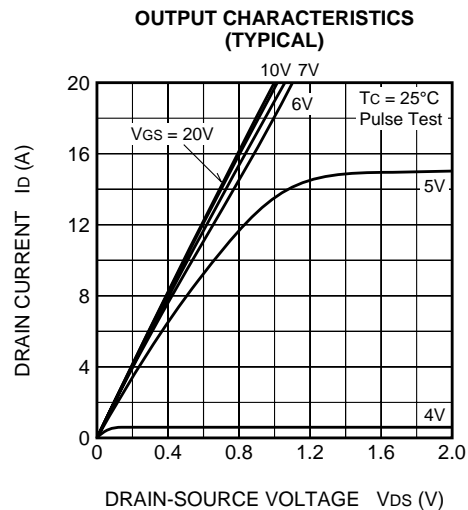
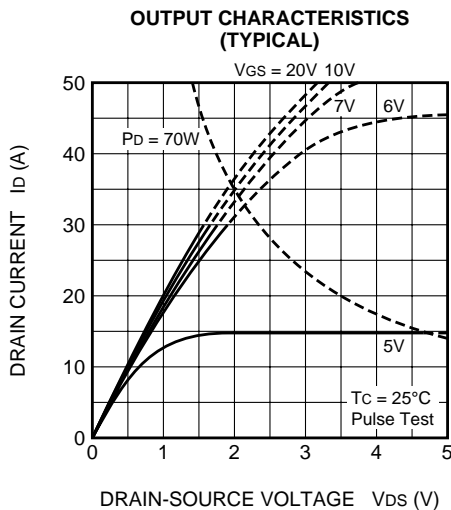
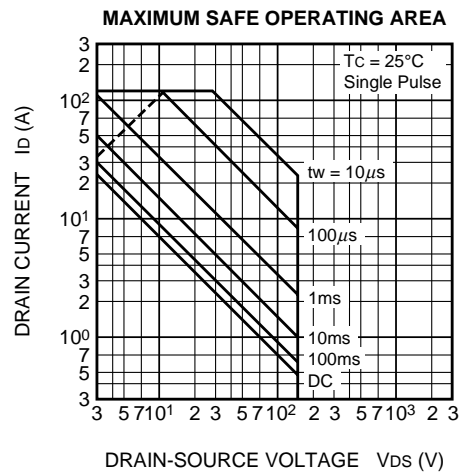
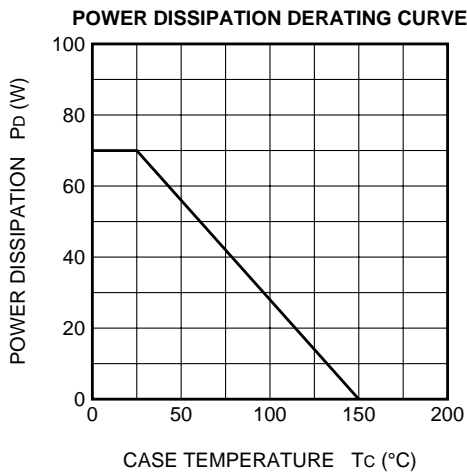
## MAXIMUM RATINGS (T<sub>c</sub> = 25°C)

Symbol	Parameter	Conditions	Ratings	Unit
V <sub>DSS</sub>	Drain-source voltage	V <sub>GS</sub> = 0V	150	V
V <sub>GSS</sub>	Gate-source voltage	V <sub>DS</sub> = 0V	±20	V
I <sub>D</sub>	Drain current		30	A
I <sub>DM</sub>	Drain current (Pulsed)		120	A
I <sub>DA</sub>	Avalanche drain current (Pulsed)	L = 100μH	30	A
I <sub>S</sub>	Source current		30	A
I <sub>SM</sub>	Source current (Pulsed)		120	A
P <sub>D</sub>	Maximum power dissipation		70	W
T <sub>ch</sub>	Channel temperature		-55 ~ +150	°C
T <sub>stg</sub>	Storage temperature		-55 ~ +150	°C
—	Weight	Typical value	2.0	g

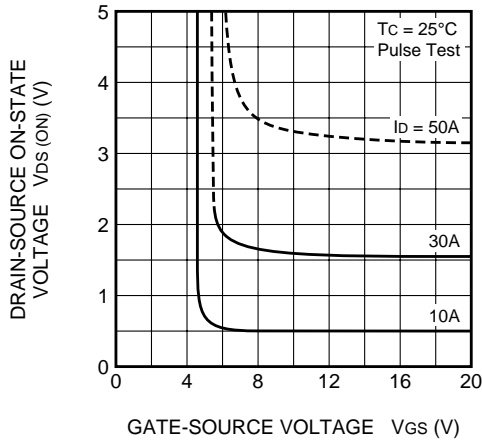
**ELECTRICAL CHARACTERISTICS** (Tch = 25°C)

Symbol	Parameter	Test conditions	Limits			Unit
			Min.	Typ.	Max.	
V(BR)DSS	Drain-source breakdown voltage	Id = 1mA, Vgs = 0V	150	—	—	V
IgSS	Gate-source leakage current	Vgs = ±20V, Vds = 0V	—	—	±0.1	μA
IbSS	Drain-source leakage current	Vds = 150V, Vgs = 0V	—	—	0.1	mA
VGS(th)	Gate-source threshold voltage	Id = 1mA, Vds = 10V	2.0	3.0	4.0	V
rDS(ON)	Drain-source on-state resistance	Id = 15A, Vgs = 10V	—	68	92	mΩ
VDS(ON)	Drain-source on-state voltage	Id = 15A, Vgs = 10V	—	1.02	1.38	V
yfs	Forward transfer admittance	Id = 15A, Vds = 10V	—	29	—	S
Ciss	Input capacitance	Vds = 10V, Vgs = 0V, f = 1MHz	—	2300	—	pF
Coss	Output capacitance		—	320	—	pF
Crss	Reverse transfer capacitance		—	130	—	pF
td(on)	Turn-on delay time	VDD = 80V, Id = 15A, Vgs = 10V, RGEN = RGS = 50Ω	—	35	—	ns
tr	Rise time		—	58	—	ns
td(off)	Turn-off delay time		—	110	—	ns
tf	Fall time		—	65	—	ns
VSD	Source-drain voltage	Is = 15A, Vgs = 0V	—	1.0	1.5	V
Rth(ch-c)	Thermal resistance	Channel to case	—	—	1.78	°C/W
trr	Reverse recovery time	Is = 30A, dis/dt = -100A/μs	—	110	—	ns

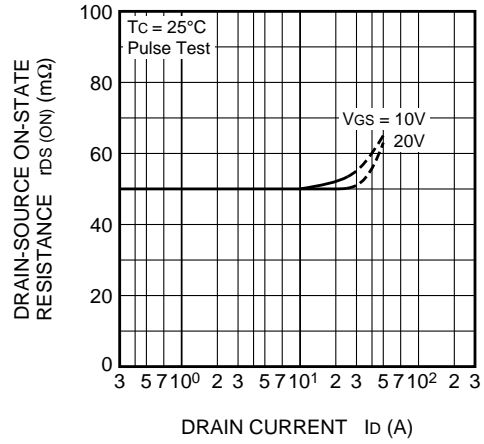
**PERFORMANCE CURVES**



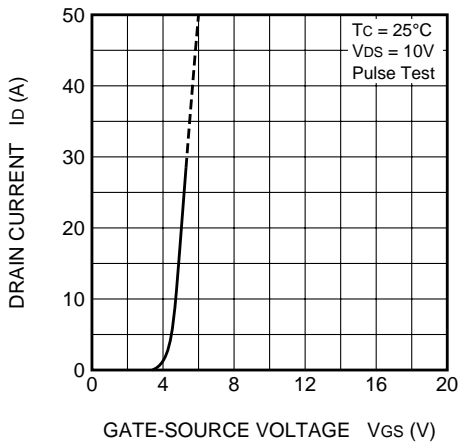
ON-STATE VOLTAGE VS. GATE-SOURCE VOLTAGE (TYPICAL)



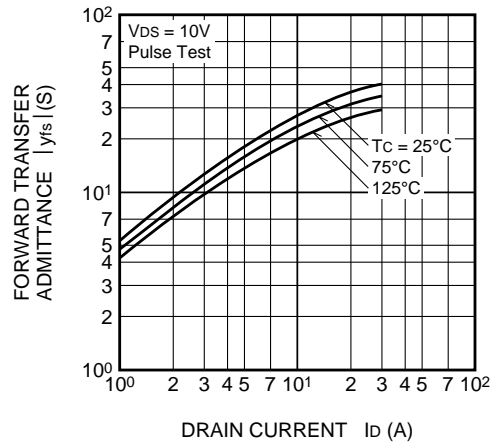
ON-STATE RESISTANCE VS. DRAIN CURRENT (TYPICAL)



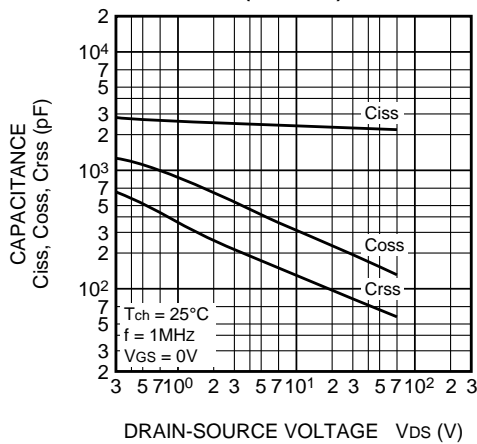
TRANSFER CHARACTERISTICS (TYPICAL)



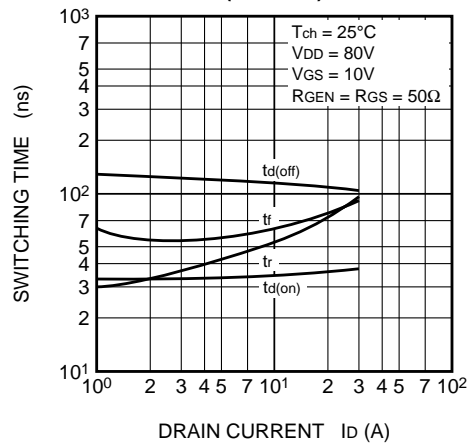
FORWARD TRANSFER ADMITTANCE VS. DRAIN CURRENT (TYPICAL)



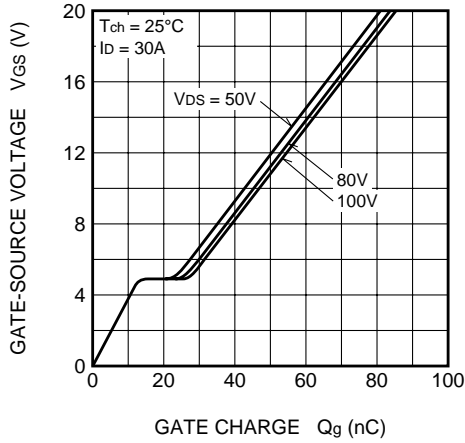
CAPACITANCE VS. DRAIN-SOURCE VOLTAGE (TYPICAL)



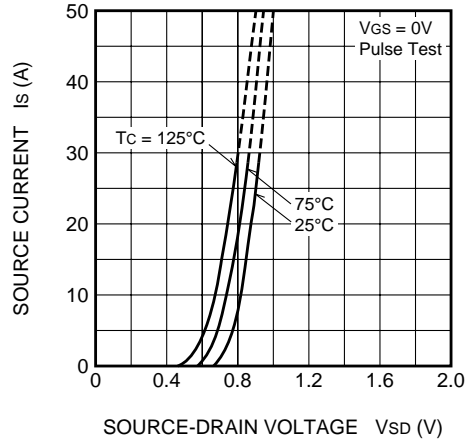
SWITCHING CHARACTERISTICS (TYPICAL)



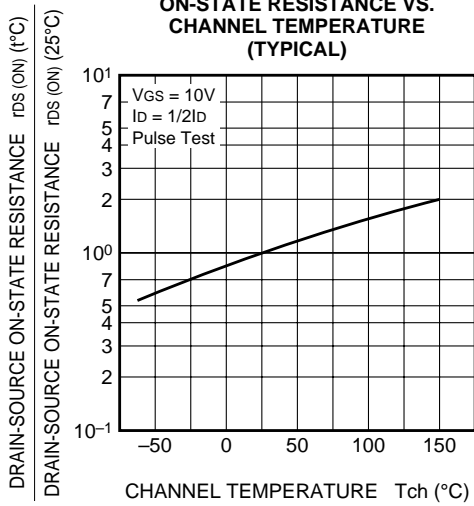
**GATE-SOURCE VOLTAGE VS. GATE CHARGE (TYPICAL)**



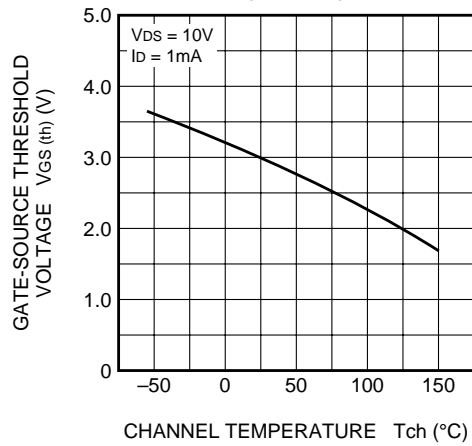
**SOURCE-DRAIN DIODE FORWARD CHARACTERISTICS (TYPICAL)**



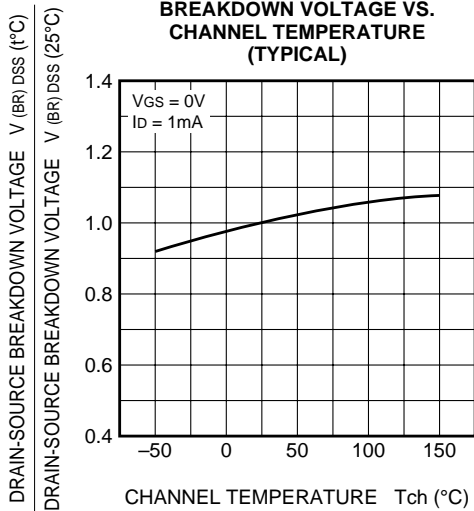
**ON-STATE RESISTANCE VS. CHANNEL TEMPERATURE (TYPICAL)**



**THRESHOLD VOLTAGE VS. CHANNEL TEMPERATURE (TYPICAL)**



**BREAKDOWN VOLTAGE VS. CHANNEL TEMPERATURE (TYPICAL)**



**TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS**

